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**MPSA13 & MPSA14**  
**Silicon NPN Transistor**  
**Darlington, General Purpose Amplifier, Preamp, Driver**  
**TO-92 Type Package**

**Absolute Maximum Ratings:** ( $T_A = +25^\circ\text{C}$  unless otherwise specified)

Collector-Emitter Voltage, $V_{CES}$	.....	30V
Collector-Base Voltage, $V_{CBO}$	.....	30V
Emitter-Base Voltage, $V_{EBO}$	.....	10V
Continuous Collector Current, $I_C$	.....	500mA
Total Device Dissipation ( $T_A = +25^\circ\text{C}$ ), $P_D$	.....	625mW
Derate Above $25^\circ\text{C}$	.....	5mW/ $^\circ\text{C}$
Total Device Dissipation ( $T_C = +25^\circ\text{C}$ ), $P_D$	.....	1.5W
Derate Above $25^\circ\text{C}$	.....	12mW/ $^\circ\text{C}$
Operating Junction Temperature Range, $T_J$	.....	-55° to +150°C
Storage Temperature Range, $T_{stg}$	.....	-55° to +150°C
Thermal Resistance, Junction-to-Case, $R_{thJC}$	.....	83.3°C
Thermal Resistance, Junction-to-Ambient, $R_{thJA}$	.....	200°C/W

**Electrical Characteristics:** ( $T_A = +25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
<b>OFF Characteristics</b>						
Collector-Emitter Breakdown Voltage	$V_{(BR)CES}$	$I_C = 100\mu\text{A}$ , $V_{BE} = 0$	30	-	-	V
Collector Cutoff Current	$I_{CBO}$	$V_{CB} = 30\text{V}$ , $I_E = 0$	-	-	100	nA
Emitter Cutoff Current	$I_{EBO}$	$V_{BE} = 10\text{V}$ , $I_C = 0$	-	-	100	nA
<b>ON Characteristics (Note 1)</b>						
DC Current Gain MPSA13	$h_{FE}$	$I_C = 10\text{mA}$ , $V_{CE} = 5\text{V}$	5,000	-	-	
MPSA14			10,000	-	-	
MPSA13		$I_C = 100\text{mA}$ , $V_{CE} = 5\text{V}$	10,000	-	-	
MPSA14			20,000	-	-	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 100\text{mA}$ , $I_B = 0.1\text{mA}$	-	-	1.5	V
Base-Emitter ON Voltage	$V_{BE(on)}$	$I_C = 100\text{mA}$ , $V_{CE} = 5\text{V}$	-	-	2.0	V
<b>Small-Signal Characteristics</b>						
Current Gain-Bandwidth Product	$f_T$	$I_C = 10\text{mA}$ , $V_{CE} = 10\text{V}$ , $f = 100\text{MHz}$ , Note 2	125	-	-	MHz

Note 1. Pulse Test: Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$

Note 2.  $f_T = |h_{fe}| \cdot f_{test}$

